

## 7NM65-FD2

## Power MOSFET

## 7A, 650V N-CHANNEL SUPER-JUNCTION MOSFET

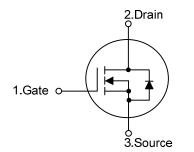
### DESCRIPTION

The **UTC 7NM65-FD2** is a Super Junction MOSFET Structure and is designed to have better characteristics, such as fast switching time, low gate charge, low on-state resistance and a high rugged avalanche characteristics. This power MOSFET is usually used at DC-DC, AC-DC converters for power applications.

### FEATURES

- \*  $R_{DS(ON)}$  < 1.0  $\Omega$  @  $V_{GS}$ =10V,  $I_D$ =3.5A
- \* By using Super Junction Structure
- \* Fast Switching
- \* With 100% Avalanche Tested

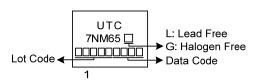
#### SYMBOL

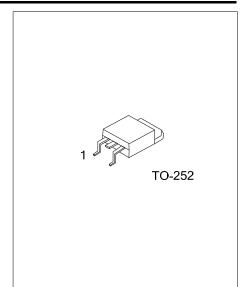




Ordering Number		Daakaga	Pin Assignment			Deaking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
7NM65L-TN3-R 7NM65G-TN3-R		TO-252	G	D	S	Tape Reel	
Note: Pin Assignment: G: Gate D: Drain S: Source							
7NM65 <u>G-TN3</u> -R	<ul> <li>(1) R: Tape Reel</li> <li>(2) TN3: TO-252</li> <li>(3) G: Halogen Free and Lead Free, L: Lead Free</li> </ul>						

#### MARKING





#### ■ ABSOLUTE MAXIMUM RATINGS (T<sub>c</sub> = 25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT	
Drain to Source Voltage		V <sub>DSS</sub>	650	V	
Gate to Source Voltage		V <sub>GSS</sub>	±30	V	
Continuous Drain Current	Continuous	I <sub>D</sub>	7	А	
Pulsed Drain Current	Pulsed (Note 2)	I <sub>DM</sub>	21	А	
Avalanche Energy	Single Pulsed (Note 3)	E <sub>AS</sub>	162	mJ	
Peak Diode Recovery dv/dt (Note 4)		dv/dt	8	V/ns	
Power Dissipation		P <sub>D</sub>	60	W	
Junction Temperature		ТJ	+150	°C	
Storage Temperature		T <sub>STG</sub>	-55 ~ +150	°C	

Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged. Absolute maximum ratings are stress ratings only and functional device operation is not implied.

2. Repetitive Rating : Pulse width limited by maximum junction temperature.

3. L=144mH,  $I_{AS}$ =1.5A,  $V_{DD}$ = 50V,  $R_{G}$ =25 $\Omega$ , Starting  $T_{J}$ =25 $^{\circ}$ C.

4.  $I_{SD} \le 10A$ , di/dt  $\le 200A/\mu s$ ,  $V_{DD} \le BV_{DSS}$ , Starting  $T_J = 25^{\circ}C$ .

#### THERMAL DATA

PARAMETER	SYMBOL	RATINGS	UNIT	
Junction to Ambient	θ <sub>JA</sub>	110	°C/W	
Junction to Case	θις	2.08	°C/W	

#### ■ ELECTRICAL CHARACTERISTICS (T<sub>J</sub> =25°C, unless otherwise specified)

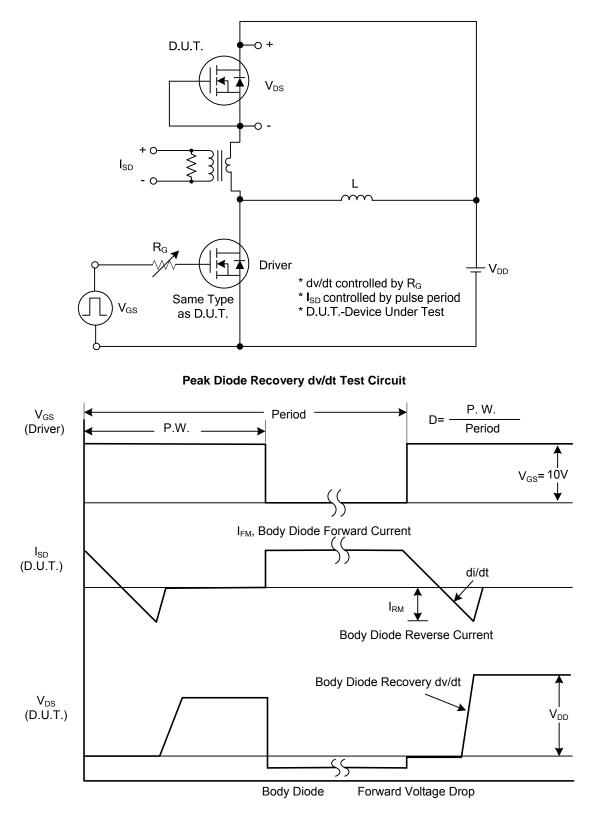
PARAMETER	SYMBOL	TEST CONDITIONS	MIN	TYP	MAX	UNIT
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	V <sub>GS</sub> =0V, I <sub>D</sub> =250µA	650			V
Drain-Source Leakage Current	I <sub>DSS</sub>	V <sub>DS</sub> =650V, V <sub>GS</sub> =0V			10	μA
Gate-Source Leakage Current	I <sub>GSS</sub>	V <sub>DS</sub> =0V ,V <sub>GS</sub> =±30V			±100	nA
ON CHARACTERISTICS						
Gate Threshold Voltage	V <sub>GS(TH)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , Ι <sub>D</sub> =250μΑ	2.5		4.5	V
Drain-Source On-State Resistance	R <sub>DS(ON)</sub>	V <sub>GS</sub> =10V, I <sub>D</sub> =3.5A			1.0	Ω
DYNAMIC PARAMETERS						
Input Capacitance	CISS			350		pF
Output Capacitance	C <sub>OSS</sub>	V <sub>DS</sub> =25V,V <sub>GS</sub> =0V, f=1.0MHz		300		pF
Reverse Transfer Capacitance	C <sub>RSS</sub>			30		pF
SWITCHING PARAMETERS						
Turn-ON Delay Time (Note 1)	t <sub>D(ON)</sub>			0.4		ns
Rise Time	t <sub>R</sub>	V <sub>DD</sub> =300V, V <sub>GS</sub> =10V,		10.2		ns
Turn-OFF Delay Time	t <sub>D(OFF)</sub>	I <sub>D</sub> =7.0A, R <sub>G</sub> =25Ω (Note 1, 2)		38		ns
Fall-Time	t <sub>F</sub>			20.2		ns
SOURCE- DRAIN DIODE RATINGS AND CHA	ARACTERIS	TICS				
Maximum Body-Diode Continuous Current	ls				7	Α
Maximum Body-Diode Pulsed Current	I <sub>SM</sub>				21	Α
Drain-Source Diode Forward Voltage (Note 1)	$V_{SD}$	I <sub>S</sub> =7.0A, V <sub>GS</sub> =0V			1.4	V
Body Diode Reverse Recovery Time (Note 1)	t <sub>rr</sub>	I <sub>S</sub> =7.0A, V <sub>GS</sub> =0V		166		ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	dI <sub>F</sub> /dt=100A/µs		1		μC
Notos: 1. Bulas Test : Bulas width < 200us. Dut						

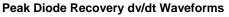
Notes: 1. Pulse Test : Pulse width  $\leq$  300µs, Duty cycle  $\leq$  2%

2. Essentially independent of operating temperature



### TEST CIRCUITS AND WAVEFORMS

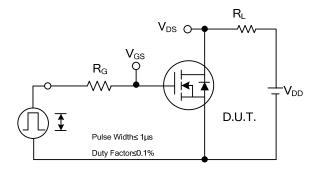


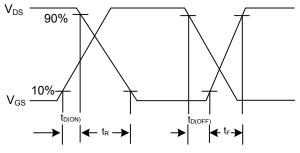




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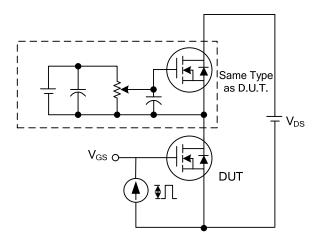
## ■ TEST CIRCUITS AND WAVEFORMS (Cont.)



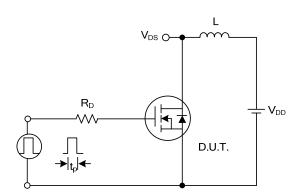


Switching Test Circuit

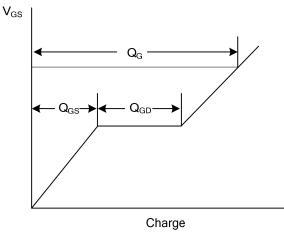




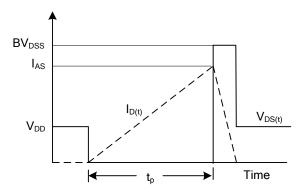
Gate Charge Test Circuit

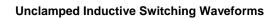


**Unclamped Inductive Switching Test Circuit** 



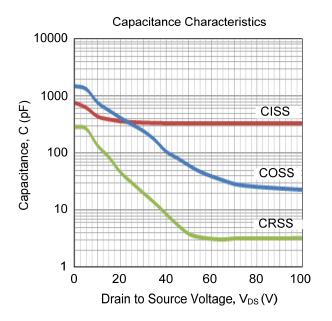






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## TYPICAL CHARACTERISTICS



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